JFET Chopper Transistor

N-Channel – Depletion

Features

• Pb–Free Package is Available

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Drain-Gate Voltage	V _{DG}	-40	Vdc
Gate-Source Voltage	V _{GS}	-35	Vdc
Gate Current	Ι _G	50	mAdc
Total Device Dissipation @ T _A = 25°C Derate above 25°C	P _D	350 2.8	mW mW/° C
Lead Temperature	TL	300	°C
Operating and Storage Junction Temperature Range	T _J , T _{stg}	-65 to +150	°C

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

ELECTRICAL CHARACTERISTICS (T_A = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Max	Unit
OFF CHARACTERISTICS				

Gate – Source Breakdown Voltage ($I_G = -1.0 \ \mu Adc$)	V _{(BR)GSS}	40	_	Vdc
Gate Reverse Current (V _{GS} = -15 Vdc)	I _{GSS}	_	-1.0	nAdc
Gate Source Cutoff Voltage $(V_{DS} = 5.0 \text{ Vdc}, I_D = 1.0 \mu \text{Adc})$	V _{GS(off)}	-0.8	-4.0	Vdc
Drain–Cutoff Current (V _{DS} = 5.0 Vdc, V _{GS} = -10 Vdc)	I _{D(off)}	-	1.0	nAdc

ON CHARACTERISTICS

Zero–Gate–Voltage Drain Current (Note 1)	I _{DSS}	8.0	80	mAdc
$(V_{DS} = 15 \text{ Vdc})$				
Static Drain–Source On Resistance (V _{DS} = 0.1 Vdc)	r _{DS(on)}	-	60	Ω
Drain Gate and Source Gate On–Capacitance $(V_{DS} = V_{GS} = 0, f = 1.0 \text{ MHz})$	C _{dg(on)} + C _{sg(on)}	-	28	pF
Drain Gate Off–Capacitance (V _{GS} = –10 Vdc, f = 1.0 MHz)	C _{dg(off)}	-	5.0	pF
Source Gate Off–Capacitance (V _{GS} = -10 Vdc, f = 1.0 MHz)	C _{sg(off)}	-	5.0	pF

1. Pulse Width = 300 μ s, Duty Cycle = 3.0%.



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MARKING DIAGRAM



6	= Device Code

M = Date Code*

Μ

= Pb-Free Package
 (Note: Microdot may be in either location)

(Note: Microdot may be in either location)

*Date Code orientation and/or overbar may vary depending upon manufacturing location.

ORDERING INFORMATION

Device	Package	Shipping [†]
BSR58LT1	SOT-23	3000/Tape & Reel
BSR58LT1G	SOT-23 (Pb-Free)	3000/Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

BSR58LT1



TYPICAL SWITCHING CHARACTERISTICS



Figure 1. Turn–On Delay Time





Figure 3. Turn–Off Delay Time





1000 $T_J = 25^{\circ}C$ 500 R_D V_{GS(off)} = 12 V J111 200 J112 J113 = 5.0 V 100 tf., FALL TIME (ns) 50 20 R_K 10 5.0 2.0 1.0 0.5 0.7 1.0 2.0 3.0 5.0 7.0 20 30 50 10 ID, DRAIN CURRENT (mA)



NOTE 1

The switching characteristics shown above were measured using a test circuit similar to Figure 5. At the beginning of the switching interval, the gate voltage is at Gate Supply Voltage ($-V_{GG}$). The Drain–Source Voltage (V_{DS}) is slightly lower than Drain Supply Voltage (V_{DD}) due to the voltage divider. Thus Reverse Transfer Capacitance (C_{rss}) or Gate–Drain Capacitance (C_{gd}) is charged to $V_{GG} + V_{DS}$.

During the turn–on interval, Gate–Source Capacitance (C_{gs}) discharges through the series combination of R_{Gen} and R_K . C_{gd} must discharge to $V_{DS(on)}$ through R_G and R_K in series with the parallel combination of effective load impedance (R'_D) and Drain–Source Resistance (r_{ds}). During the turn–off, this charge flow is reversed.

Predicting turn–on time is somewhat difficult as the channel resistance r_{ds} is a function of the gate–source voltage. While C_{gs} discharges, V_{GS} approaches zero and r_{ds} decreases. Since C_{gd} discharges through r_{ds} , turn–on time is non–linear. During turn–off, the situation is reversed with r_{ds} increasing as C_{gd} charges.

The above switching curves show two impedance conditions; 1) R_K is equal to R_D , which simulates the switching behavior of cascaded stages where the driving source impedance is normally the load impedance of the previous stage, and 2) $R_K = 0$ (low impedance) the driving source impedance is that of the generator.

BSR58LT1



Figure 6. Typical Forward Transfer Admittance

200

160

120

80

40

0

0

^{rds(on)}, DRAIN-SOURCE ON-STATE RESISTANCE (OHMS)









Figure 10. Effect of I_{DSS} On Drain–Source **Resistance and Gate-Source Voltage**

170

Figure 9. Effect of Temperature On Drain-Source On-State Resistance

NOTE 2

The Zero–Gate–Voltage Drain Current (I_{DSS}), is the principle determinant of other J-FET characteristics. Figure 10 shows the relationship of Gate-Source Off Voltage (VGS(off) and Drain-Source On Resistance (rds(on)) to IDSS. Most of the devices will be within $\pm 10\%$ of the values shown in Figure 10. This data will be useful in predicting the characteristic variations for a given part number.

For example:

Unknown

rds(on) and VGS range for an J112

The electrical characteristics table indicates that an J112 has an I_{DSS} range of 25 to 75 mA. Figure 10, shows $r_{ds(on)} = 52 \Omega$ for I_{DSS} = 25 mA and 30 Ω for I_{DSS} = 75 mA. The corresponding V_{GS} values are 2.2 V and 4.8 V.

BSR58LT1

PACKAGE DIMENSIONS

SOT-23 (TO-236)

CASE 318-08 ISSUE AL



NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 CONTROLLING DIMENSION: INCH.
- CONTROLLING DIMENSION: INCH.
 MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH THICKNESS. MINIMUM LEAD
- FINISH THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL.
- 4. 318–01 THRU –07 AND –09 OBSOLETE, NEW STANDARD 318–08.

	MILLIMETERS			INCHES		
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	0.89	1.00	1.11	0.035	0.040	0.044
A1	0.01	0.06	0.10	0.001	0.002	0.004
b	0.37	0.44	0.50	0.015	0.018	0.020
C	0.09	0.13	0.18	0.003	0.005	0.007
D	2.80	2.90	3.04	0.110	0.114	0.120
Е	1.20	1.30	1.40	0.047	0.051	0.055
е	1.78	1.90	2.04	0.070	0.075	0.081
L	0.35	0.54	0.69	0.014	0.021	0.029
HE	2.10	2.40	2.64	0.083	0.094	0.104

STYLE 10:

- PIN 1. DRAIN 2. SOURCE
 - 3. GATE

SOLDERING FOOTPRINT*



*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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